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Application/Control No.	Applicant(s)/Patent under Reexamination		
10/749,868	CHOU ET AL.	CHOU ET AL.	
Examiner	Art Unit	Art Unit	
Susan S. Lee	2852	2852	

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	SEAR	CHED	
Class	Subclass	Date	Examiner
399	57, 237	9/18/2005	SL
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH (INCLUDING SEAR	NOTES	ATEGY)	
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